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ANALOG Dual-Channel, 14-Bit CCD Signal Processor with Processor Timing TM Core with *Precision Timing*™ Core

AD9942

FEATURES

40 MHz correlated double sampler (CDS) 0 dB to 18 dB, 9-bit variable gain amplifier (VGA) 40 MSPS analog-to-digital converter (ADC) Optical black clamp (CLPOB) with variable level control Complete on-chip timing driver Precision Timing core with <550 ps resolution On-chip 3 V horizontal and RG drivers 4-phase H-clock mode 100-lead, 9 mm × 9 mm, CSP_BGA package

APPLICATIONS

Signal processor for dual-channel CCD outputs **Digital still cameras Digital video cameras** High speed digital imaging applications

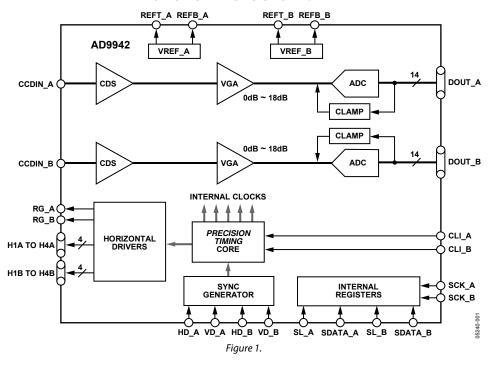
GENERAL DESCRIPTION

The AD9942 is a highly integrated dual-channel CCD signal processor for digital still camera applications. Each channel is specified at pixel rates of up to 40 MHz. The AD9942 consists of a complete analog front end with analog-to-digital conversion, combined with a programmable timing driver. The Precision Timing core allows high speed clocks to be adjusted with 550 ps resolution.

The analog front end uses black level clamping and includes a VGA, a 40 MSPS ADC, and a CDS. The timing driver provides the high speed CCD clock drivers for RG A and RG B, as well as the H1A to H4A and H1B to H4B outputs. The 6-wire serial interface is used to program the AD9942.

Available in a space-saving, 9 mm × 9 mm, CSP_BGA package, the AD9942 is specified over an operating temperature range of -25°C to +85°C.

FUNCTIONAL BLOCK DIAGRAM



AD9942* PRODUCT PAGE QUICK LINKS

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DOCUMENTATION

Data Sheet

 AD9942: Dual-Channel, 14-Bit, CCD Signal Processor with Precision Timing™ Core Data Sheet

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- · AD9942 Material Declaration
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- · Quality And Reliability
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TABLE OF CONTENTS

Features	High Speed Clock Programmability
Applications	H Driver and RG Outputs21
General Description	Digital Data Outputs21
Functional Block Diagram	Channel A and Channel B Horizontal Clamping and Blanking22
Revision History	Individual CLPOB and PBLK Sequences
Specifications	Individual HBLK Sequences
General Specifications	Channel A and Channel B Special HBLK Patterns 24
Digital Specifications4	Horizontal Sequence Control
Analog Specifications5	H-Counter Synchronization
Channel-to-Channel Specifications6	Channel A and Channel B Power-Up Procedure
Timing Specifications	Channel A and Channel B Analog Front End Operation 27
Absolute Maximum Ratings	DC Restore
Thermal Resistance	Correlated Double Sampler
ESD Caution	Channel A and Channel B Variable Gain Amplifier 28
Pin Configuration and Function Descriptions9	Channel A and Channel B ADC28
Terminology11	Channel A and Channel B CLPOB28
Equivalent Input/Output Circuits	Channel A and Channel B Digital Data Outputs 28
Typical Performance Characteristics	Applications Information
System Overview	Circuit Configuration
Serial Interface Timing	Grounding/Decoupling Recommendations29
Complete Register Listing	Driving the CLI Input31
Channel A and Channel B Precision Timing	Horizontal Timing Sequence Example31
High Speed Timing Generation	Outline Dimensions
Timing Resolution	Ordering Guide
REVISION HISTORY	
8/06—Rev. 0 to Rev. A Changes to Table 3	
1/05 Davision 0. Initial Varsian	

SPECIFICATIONS

GENERAL SPECIFICATIONS

X = A, B.

Table 1.

Parameter	Min	Тур	Max	Unit		
TEMPERATURE RANGE						
Operating	-25		+85	°C		
Storage	-65		+150	°C		
MAXIMUM CLOCK RATE	40			MHz		
POWER SUPPLY VOLTAGE						
AVDD_X, TCVDD_X (AFE, Timing Core)	2.7	3.0	3.6	V		
HVDD_X (H1X to H4X Drivers)	2.7	3.0	3.6	V		
RGVDD_X (RG_X Driver)	2.7	3.0	3.6	V		
DRVDD_X (D0 to D13 Drivers)	2.7	3.0	3.6	V		
DVDD_X (Digital)	2.7	3.0	3.6	V		
POWER DISSIPATION FOR EACH CHANNEL (40 MHz, 3 V Supplies, 100 pF H1X to H4X Loading, 10 pF RG_X Loading)						
Power from AVDD X		110		mW		
Power from TCVDD_X		33		mW		
Power from HVDD_X ¹		160		mW		
Power from RGVDD X						
Power from DRVDD_X		15		mW		
Power from DVDD_X 40						
Total Shutdown Mode		2		mW		

 $^{^{1}\,} Total\,\, HVDD_X\,\, Power = [(C_{LOAD})\times (HVDD_X)\times (Pixel\,\, Frequency)]\times (HVDD_X)\times (Number\,\, of\,\, Horizontal\,\, Outputs\,\, Used).$

DIGITAL SPECIFICATIONS

 T_{MIN} to T_{MAX} , $AVDD_X = DVDD_X = DRVDD_X = HVDD_X = RGVDD_X = 2.7 \text{ V}$, $C_L = 20 \text{ pF}$, unless otherwise noted. X = A, B.

Table 2.

Parameter	Symbol	Min	Тур	Max	Unit
LOGIC INPUTS					
High Level Input Voltage	V _{IH}	2.1			V
Low Level Input Voltage	VIL			0.6	V
High Level Input Current	I _{IH}		10		μΑ
Low Level Input Current	IIL		10		μΑ
Input Capacitance	C _{IN}		10		pF
LOGIC OUTPUTS					
High Level Output Voltage, I _{OH} = 2 mA	V _{OH}	2.2			V
Low Level Output Voltage, $I_{OL} = 2 \text{ mA}$	V _{OL}			0.5	V
CLI INPUT					
High Level Input Voltage (TCVDD_X/2 + 0.5 V)	V _{IH} – CLI	1.85			V
Low Level Input Voltage	V _{IL} – CLI			0.85	V
RG_X AND H1X TO H4X DRIVER OUTPUTS					
High Level Output Voltage (RGVDD_X – 0.5 V and HVDD_X – 0.5 V)	Vон	2.2			V
Low Level Output Voltage	V _{OL}			0.5	V
Maximum Output Current (Programmable)			30		mA
Maximum Load Capacitance		100			pF

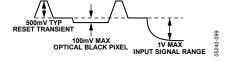
ANALOG SPECIFICATIONS

 T_{MIN} to T_{MAX} , $AVDD_X = DVDD_X = 3.0 \text{ V}$, $f_{\text{CLI}} = 40 \text{ MHz}$, typical timing specifications, unless otherwise noted. X = A, B.

Table 3.

Parameter	Min	Тур	Max	Unit	Notes
CDS					
Gain		0		dB	
Allowable CCD Reset Transient ¹		500		mV	
Max Input Range Before Saturation	1.0			V p-p	
Max CCD Black Pixel Amplitude		±100		mV	Measured at 12 dB VGA gain (Typ = 70 mV at 15 dB and 50 mV at 18 dB)
VARIABLE GAIN AMPLIFIER (VGA_X)					
Max Input Range	1.0			V p-p	
Max Output Range	2.0			V p-p	
Gain Control Resolution		512		Steps	
Gain Monotonicity		Guaranteed			
Gain Range					
Min Gain (Code 0)		0		dB	
Max Gain (Code 511)		18		dB	
CLPOB					
Clamp Level Resolution		256		Steps	4 LSB/step
Clamp Level					Measured at ADC output
Min Clamp Level		0		LSB	
Max Clamp Level		1023		LSB	
CHN_A AND CHN_B ADC					
Differential Nonlinearity (DNL)	-1.0	± 0.5	+1.0	LSB	
No Missing Codes		Guaranteed			
Full-Scale Input Voltage		2.0		V	
VOLTAGE REFERENCE					
Reference Top Voltage (REFT_X)		2.0		٧	
Reference Bottom Voltage (REFB_X)		1.0		٧	
SYSTEM PERFORMANCE					Specifications include entire signal chain
VGA Gain Accuracy					
Min Gain (Code 0)	-0.5	0	+0.5	dB	
Max Gain (Code 511)	17.5	18	18.5	dB	
Peak Nonlinearity, 500 mV Input Signal		0.15		%	12 dB gain applied
Total Output Noise		3		LSB rms	AC grounded input, 6 dB gain applied
Power Supply Rejection (PSR)		50		dB	Measured with step change on supply

¹ Input signal characteristics defined as follows:



CHANNEL-TO-CHANNEL SPECIFICATIONS

 T_{MIN} to T_{MAX} , AVDD_X = DVDD_X = 3.0 V, f_{CLI} = 40 MHz, typical timing specifications, unless otherwise noted. X = A, B.

Table 4.

Parameter	Min	Тур	Max	Unit	Notes
CHANNEL A/CHANNEL B OUTPUT CODE MATCHING ERROR ¹		<1.0%			VGA = 6 dB, 12 dB, and 18 dB conditions.
CROSSTALK ERROR					VGA = 6 dB, 12 dB, and 18 dB conditions.
Channel A to Channel B		-84		dB	Full-scale step applied to Channel A while measuring response on Channel B.
Channel B to Channel A		-84		dB	Full-scale step applied to Channel B while measuring response on Channel A.

¹ Matching error calculated using a ramp input applied to Channel A and Channel B simultaneously. Typical Channel A/Channel B error is <1.0% at each output code.

TIMING SPECIFICATIONS

 $C_L = 20$ pF, $f_{CLI} = 40$ MHz, serial timing in Figure 14 and Figure 15, unless otherwise noted. X = A, B.

Table 5.

Parameter	Symbol	Min	Тур	Max	Unit
MASTER CLOCK (CLI_X) (See Figure 16)					
CLI_X Clock Period		25.0			ns
CLI_X High/Low Pulse Width	t _{ADC}	10.0	12.5	15.0	ns
Delay from CLI_X to Internal Pixel Period Position (See Figure 16)	tclidly		6		ns
CLPOB_X PULSE WIDTH (Programmable) ¹	t _{COB}	2	20		Pixels
SAMPLE CLOCKS (See Figure 17)					
SHP_X Rising Edge to SHD_X Rising Edge	t _{S1}	11.2	12.5		ns
DATA OUTPUTS (See Figure 19 and Figure 20)					
Output Delay from Programmed Edge	toD		6		ns
Pipeline Delay			11		Cycles
SERIAL INTERFACE					
Maximum SCK_X Frequency	f _{SCLK}	10			MHz
SL_X to SCK_X Setup Time	t _{LS}	10			ns
SCK to SL_X Hold Time	t _{LH}	10			ns
SDATA_X Valid to SCK_X Rising Edge Setup	t _{DS}	10			ns
SCK_X Falling Edge to SDATA_X Valid Hold	t _{DH}	10			ns
SCK_X Falling Edge to SDATA_X Valid Read	t _{DV}	10			ns

 $^{^{1}}$ Minimum CLPOB pulse width is for functional operation only. Wider typical pulses are recommended to achieve low noise clamp reference.

ABSOLUTE MAXIMUM RATINGS

Table 6. Ratings (X = A, B)

Parameter	Rating
AVDD_X and TCVDD_X to AVSS_X	−0.3 V to +3.9 V
HVDD_X and RGVDD_X to HVSS_X and RGVSS_X	-0.3 V to +3.9 V
DVDD_X and DRVDD_X to DVSS_X and DRVSS_X	-0.3 V to +3.9 V
Any VSS_X to Any VSS_X	−0.3 V to +0.3 V
Digital Outputs to DRVSS_X	-0.3 V to DRVDD + 0.3 V
SCK_X, SL_X, and SDATA_X to DVSS_X	-0.3 V to DVDD + 0.3 V
RG_X to RGVSS_X	-0.3 V to RGVDD + 0.3 V
H1X to H4X to HVSS_X	-0.3 V to HVDD + 0.3 V
REFT_X, REFB_X, and CCDIN_X to AVSS_X	-0.3 V to AVDD + 0.3 V
Junction Temperature	150°C
Lead Temperature (10 sec)	300°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

100-lead, 9 mm × 9 mm, CSP_BGA package: $\theta_{JA} = 38.3$ °C/W¹

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



 $^{^1\,\}theta_{JA}$ is measured using a 4-layer PCB with the exposed paddle soldered to the board.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

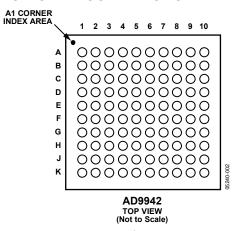


Figure 2. Pin Configuration

Table 7. Pin Function Descriptions

Ball Location	Mnemonic	Type ¹	Description
B2	SL_A	DI	6-Wire Serial Load for Channel A
C2	SDATA_A	DI	6-Wire Serial Data for Channel A
D2	SCK_A	DI	6-Wire Serial Clock for Channel A
C1	REFT_A	AO	Reference Top Decoupling for Channel A (decouple with 1.0 μF to AVSS_A)
D1	REFB_A	AO	Reference Bottom Decoupling for Channel A (decouple with 1.0 μF to AVSS_A)
A1	CCDIN_A	Al	Analog Input for Channel A CCD Signal (connect through series 0.1 µF capacitor)
F4	H1A	DO	CCD Horizontal Clock 1 for Channel A
F3	H2A	DO	CCD Horizontal Clock 2 for Channel A
D4	НЗА	DO	CCD Horizontal Clock 3 for Channel A
D3	H4A	DO	CCD Horizontal Clock 4 for Channel A
B4	RG_A	DO	CCD Reset Gate Clock for Channel A
J2	DRVSS_A	Р	Digital Driver Ground for Channel A
K3	DRVDD_A	Р	Digital Driver Supply for Channel A
E3	HVSS_A	Р	H1A to H4A Driver Ground for Channel A
E4	HVDD_A	Р	H1A to H4A Driver Supply for Channel A
C3	RGVSS_A	Р	RG_A Driver Ground for Channel A
C4	RGVDD_A	Р	RG_A Driver Supply for Channel A
B3	TCVSS_A	Р	Analog Ground for Channel A Timing Core
A4	TCVDD_A	Р	Analog Supply for Channel A Timing Core
B1	AVSS_A	Р	Analog Ground for Channel A
A2	AVDD_A	Р	Analog Ground for Channel A
F2	DVSS_A	Р	Digital Ground for Channel A
F1	DVDD_A	Р	Digital Supply for Channel A
E2	VD_A	DI	Vertical Sync Pulse for Channel A
E1	HD_A	DI	Horizontal Sync Pulse for Channel A
B8	SL_B	DI	6-Wire Serial Load for Channel B
C8	SDATA_B	DI	6-Wire Serial Data for Channel B
D8	SCK_B	DI	6-Wire Serial Clock for Channel B
C7	REFT_B	AO	Reference Top Decoupling for Channel B (decouple with 1.0 μF to AVSS_B)
D7	REFB_B	AO	Reference Bottom Decoupling for Channel B (decouple with 1.0 μF to AVSS_B)
A7	CCDIN_B	Al	Analog Input for Channel B CCD Signal (connect through series 0.1 µF capacitor)
F10	H1B	DO	CCD Horizontal Clock 1 for Channel B
F9	H2B	DO	CCD Horizontal Clock 2 for Channel B
D10	H3B	DO	CCD Horizontal Clock 3 for Channel B

Ball Location	Mnemonic	Type ¹	Description
D9	H4B	DO	CCD Horizontal Clock 4 for Channel B
B10	RG_B	DO	CCD Reset Gate Clock for Channel B
J8	DRVSS_B	P	Digital Driver Ground for Channel B
K9	DRVDD_B	P	Digital Driver Ground for Channel B
E9	HVSS_B	P	H1B to H4B Driver Ground for Channel B
E10	HVDD_B	P	H1B to H4B Driver Supply for Channel B
C9	RGVSS_B	P	RG_B Driver Ground for Channel B
C10	RGVDD_B	P	RG_B Driver Supply for Channel B
B9	TCVSS_B	P	Analog Ground for Channel B Timing Core
A10	TCVDD_B	P	Analog Supply for Channel B Timing Core
B7	AVSS_B	P	Analog Ground for Channel B
A8	AVDD_B	P	Analog Ground for Channel B
F8	DVSS_B	P	Digital Ground for Channel B
F7	DVDD_B	P	Digital Supply for Channel B
E8	VD_B	DI	Vertical Sync Pulse for Channel B
E7		DI	Horizontal Sync Pulse for Channel B
A3	HD_B CLI_A	DI	Master Clock Input for Channel A
G1		DO	
H1	D0_A	DO	Data Output Channel A
	D1_A		Data Output Channel A
J1 K1	D2_A	DO DO	Data Output Channel A Data Output Channel A
	D3_A		
G2 H2	D4_A	DO	Data Output Channel A
п2 K2	D5_A	DO	Data Output Channel A Data Output Channel A
G3	D6_A	DO	
	D7_A	DO	Data Output Channel A Data Output Channel A
H3	D8_A	DO	
J3	D9_A	DO	Data Output Channel A Data Output Channel A
K4 J4	D10_A	DO DO	Data Output Channel A Data Output Channel A
)4 H4	D11_A D12_A	DO	Data Output Channel A Data Output Channel A
п 4 G4		DO	Data Output Channel A Data Output Channel A
	D13_A GND	P	Ground Connection
A5, B5, C5, D5, E5, F5, G5, H5, J5, K5,	GND		Ground Connection
A6, B6, C6, D6, E6,			
F6, G6, H6, J6, K6			
A9	CLI_B	DI	Master Clock Input for Channel B
G7	D0_B	DO	Data Output Channel B
H7	D1_B	DO	Data Output Channel B
J7	D2_B	DO	Data Output Channel B
K7	D3_B	DO	Data Output Channel B
G8	D4_B	DO	Data Output Channel B
H8	D5_B	DO	Data Output Channel B
K8	D6_B	DO	Data Output Channel B
G9	D7_B	DO	Data Output Channel B
H9	D8_B	DO	Data Output Channel B
J9	D9_B	DO	Data Output Channel B
K10	D10_B	DO	Data Output Channel B
J10	D11_B	DO	Data Output Channel B
H10	D12_B	DO	Data Output Channel B
G10	D13_B	DO	Data Output Channel B

 $^{^{1}}$ Al = analog input, AO = analog output, DI = digital input, DO = digital output, P = power.

TERMINOLOGY

Differential Nonlinearity (DNL)

An ideal ADC exhibits code transitions that are exactly 1 LSB apart. DNL is the deviation from this ideal value. Therefore, every code must have a finite width. No missing codes guaranteed to 12-bit resolution indicates that all 4096 codes must be present over all operating conditions.

Peak Nonlinearity

Peak nonlinearity, a full signal chain specification, refers to the peak deviation of the output of the AD9942 from a true straight line. The point used as zero scale occurs 0.5 LSB before the first code transition. Positive full scale is defined as a level 1 LSB and 0.5 LSB beyond the last code transition. The deviation is measured from the middle of each particular output code to the true straight line. The error is then expressed as a percentage of the 2 V ADC full-scale signal. The input signal is always appropriately gained up to fill the ADC's full-scale range.

Total Output Noise

The rms output noise is measured using histogram techniques. The standard deviation of the ADC output codes is calculated in LSB and represents the rms noise level of the total signal chain at the specified gain setting. The output noise can be converted to an equivalent voltage, using the relationship

$$1 LSB = (ADC full scale/2^n codes)$$

where *n* is the bit resolution of the ADC. For the AD9942, 1 LSB is approximately 122.0 μ V.

Power Supply Rejection (PSR)

The PSR is measured with a step change applied to the supply pins. The PSR specification is calculated from the change in the data outputs for a given step change in the supply voltage.

Matching Error

The matching error refers to the Channel A to Channel B mismatch after post-ADC correction calibration has been applied to remove gain error between Channel A and Channel B.

Crosstalk

The crosstalk is measured while applying a full-scale step to one channel and measuring the interference on the opposite channel.

Crosstalk (dB) =
$$20 \times log \left(\frac{Interference (LSB)}{16,384} \right)$$

EQUIVALENT INPUT/OUTPUT CIRCUITS

X = A, B.

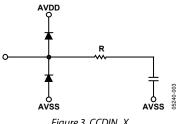
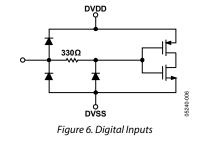
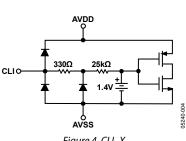
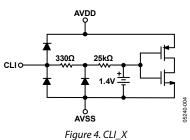
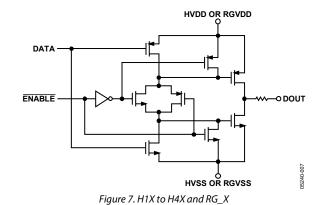


Figure 3. CCDIN_X









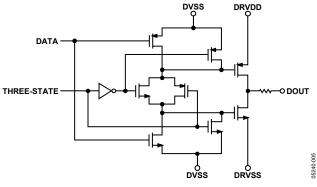


Figure 5. Data Outputs D0_X to D13_X

TYPICAL PERFORMANCE CHARACTERISTICS

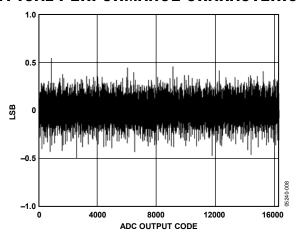


Figure 8. DNL for Channel A and Channel B

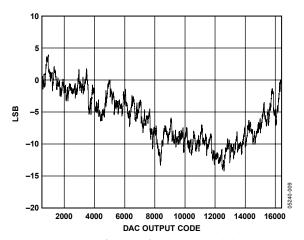


Figure 9. INL Performance for Channel A and Channel B

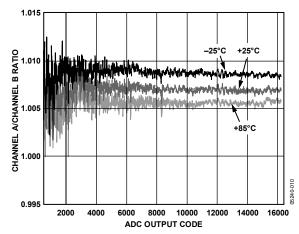


Figure 10. Noncalibrated Channel A/Channel B Ratio

SYSTEM OVERVIEW

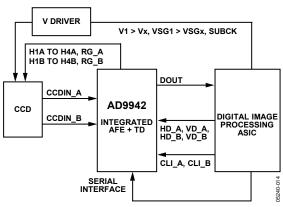


Figure 11. Typical Application

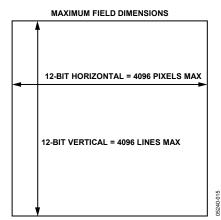


Figure 12. Vertical and Horizontal Counters

Figure 11 shows the typical system application diagram for the AD9942. The CCD output is processed by the AD9942 AFE circuitry, which consists of a CDS, a VGA, a CLPOB, and an ADC. The digitized pixel information is sent to the digital image processor chip, where all postprocessing and compression occurs. To operate the CCD, CCD timing parameters are programmed from the image processor to the AD9942 through the 6-wire serial interface. From the system master clock, CLI, which is provided by the image processor, the device generates the high speed CCD clocks and internal AFE clocks. All AD9942 clocks are synchronized with VD_X and HD_X. The CLPOB is programmed and generated internally.

The H drivers for H1A to H4A, H1B to H4B, RG_A, and RG_B are included in the AD9942, allowing these clocks to be directly connected to the CCD. An H driver voltage of 3 V is supported in the AD9942.

Figure 12 shows the horizontal and vertical counter dimensions for the device. All internal horizontal clocking is programmed using these dimensions to specify line and pixel locations.

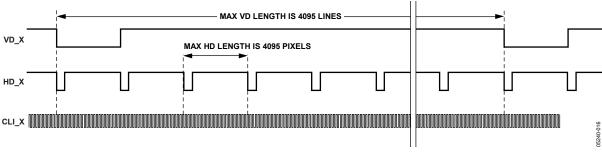
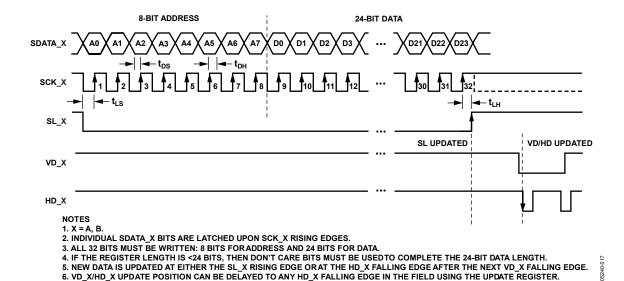


Figure 13. Maximum VD_X/HD_X Dimensions

SERIAL INTERFACE TIMING

All of the AD9942 internal registers are accessed through a 6-wire serial interface. Each register consists of an 8-bit address and a 24-bit data-word. Both the 8-bit address and the 24-bit data-word are written starting with the LSB. To write to each register, a 32-bit operation is required, as shown in Figure 14. Although many registers are less than 24 bits wide, all 24 bits must be written for each register. If the register is only 16 bits wide, then the upper 8 bits can be filled with 0s during the serial write operation. If fewer than 24 bits are written, the register is not updated with new data.

Figure 15 shows a more efficient way to write to the registers by using the AD9942 address auto-increment capability. In this method, the lowest desired address is written first, followed by multiple 24-bit data-words. Each new 24-bit data-word is written automatically to the next highest register address. By eliminating the need to write each 8-bit address, faster register loading is achieved. The address auto-increment function can be used, starting with any register location, to write to as few as two registers or to as many as the entire register space.



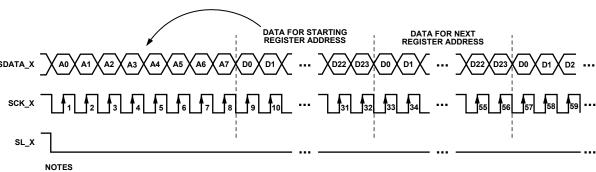


Figure 14. Serial Write Operation

- 1. X = A, B.
 2. MULTIPLE SEQUENTIAL REGISTERS CAN BE LOADED CONTINUOUSLY.
- 3. THE FIRST (LOWEST ADDRESS) REGISTER ADDRESS IS WRITTEN, FOLLOWED BY MULTIPLE 24-BIT DATA-WORDS.
- 4. THE ADDRESS AUTOMATICALLY INCREMENTS WITH EACH 24-BIT DATA-WORD (ALL 24 BITS MUST BE WRITTEN). 5. SLIX IS HELD LOW UNTIL THE LAST DESIRED REGISTER HAS BEEN LOADED.
- 6. NEW DATA IS UPDATED AT EITHER THE SL RISING EDGE OR AT THE HD FALLING EDGE AFTER THE NEXT VD FALLING EDGE.

Figure 15. Continuous Serial Write Operation

COMPLETE REGISTER LISTING

In Table 8 through Table 16, note the following:

- All addresses and default values are expressed in hexadecimal format.
- All registers are VD_X/HD_X updated as shown in Figure 14, except for the registers indicated in Table 8, which are SL_X updated.
- Each channel is programmed independently using the 5-wire serial interface. Both channels can be programmed with the same register values by tying the SL_A and SL_B signals together and the SDATA_A and SDATA_B signals together.

Table 8. Updated Registers upon Rising Edge of SL X

Register	Description		
OPRMODE	AFE operation modes		
CTLMODE	AFE control modes		
SW_RESET	Software reset bit		
TGCORE _RSTB	Reset bar signal for internal TG core		
PREVENTUPDATE	Prevents update of registers		
VDHDEDGE	VD/HD active edge		
FIELDVAL	Resets internal field pulse		
HBLKRETIME	Retimes the HBLK to internal clock		
H1CONTROL	H1 polarity control		
RGCONTROL	RG signal control polarity		
DRVCONTROL	Drive-strength control		
SAMPCONTROL	SHP/SHD sample control		
DOUTPHASE	DOUT phase control		

Table 9. CHN_A and CHN_B AFE Register Map

Address	Data Bit Content	Default (Hex)	Name	Description
00	[11:0]	4	OPRMODE	AFE operation modes (see Table 15).
01	[9:0]	0	TESTMODE	Internal test mode. Should always be set = 0.
02	[7:0]	80	CLAMP LEVEL	CLPOB level.
03	[11:0]	4	CTLMODE	AFE control modes (see Table 16).
04	[17:0]	0	TESTMODE	Test operation only. Set = 0.
05	[17:0]	0	TESTMODE	Test operation only. Set = 0.

Table 10. CHN_A and CHN_B Miscellaneous Register Map

Address	Data Bit Content	Default (Hex)	Name	Description
10	[0]	0	SW_RST	Software reset.1 = reset all registers to default, then self-clear back to 0.
11	[0]	0	OUT_CONTROL	Output control. 0 = make all dc outputs inactive.
12	[0]	0	TGCORE_RSTB	Timing core reset bar. 0 = reset TG core; 1 = resume operation.
13	[11:0]	0	UPDATE	Serial update. Sets the line (HD) within the field to update serial data.
14	[0]	0	PREVENTUPDA TE	Prevents the update of the VD-updated registers. 1 = prevent update.
15	[0]	0	VDHDEDGE	VD/HD active edge. 0 = falling edge triggered; 1 = rising edge triggered.
16	[1:0]	0	FIELDVAL	Field value sync. 0 = next field 0; 1 = next field 1; 2/3 = next field 2.
17	[0]	0	HBLKRETIME	Retime HBLK to internal H1 clock. Preferred setting is 1. Setting to 1 adds one cycle delay to HBLK toggle positions.
18	[1:0]	0	TEST MODE	Internal test mode. Should always be set = 0.
19	[0]	0	TEST MODE	Internal test mode. Should always be set = 0.
1A	[0]	0	TEST MODE	Internal test mode. Should always be set = 0.
E8	[2:0]		TEST MODE	Internal test mode. Should always be set = 0.
	[11:3]	0	VGAGAIN	VGA gain control.

Table 11. CHN_A and CHN_B CLPOB Register Map

Address	Data Bit Content	Default (Hex)	Name	Description (the CLPOBSCP0 Always Starts at Line 0)
20	[3:0]	F	CLPOBPOL	Start polarities for CLPOB Sequences 0, 1, 2, and 3.
21	[23:0]	FFFFFF	CLPOBTOG_0	Sequence 0. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
22	[23:0]	FFFFFF	CLPOBTOG_1	Sequence 1. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
23	[23:0]	FFFFFF	CLPOBTOG_2	Sequence 2. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
24	[23:0]	FFFFFF	CLPOBTOG_3	Sequence 3. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
25	[7:0]	00	CLPOBSPTR	CLPOB sequence pointers for Region 0 [1:0], 1 [3:2], 2 [5:4], and 3 [7:6].
26	[11:0]	FFF	CLPOBSCP1	CLPOB sequence—Change Position 1.
27	[11:0]	FFF	CLPOBSCP2	CLPOB sequence—Change Position 2.
28	[11:0]	FFF	CLPOBSCP3	CLPOB sequence—Change Position 3.

Table 12. PBLK Register Map

Address	Data Bit Content	Default (Hex)	Name	Description (the PBLKSCP0 Always Starts at Line 0)
30	[3:0]	F	PBLKPOL	Start polarities for PBLK Sequences 0, 1, 2, and 3.
31	[23:0]	FFFFFF	PBLKTOG_0	Sequence 0. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
32	[23:0]	FFFFFF	PBLKTOG_1	Sequence 1. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
33	[23:0]	FFFFFF	PBLKTOG_2	Sequence 2. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
34	[23:0]	FFFFFF	PBLKTOG_3	Sequence 3. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
35	[7:0]	00	PBLKSPTR	PBLK Sequence Pointers for Region 0 [1:0], 1 [3:2], 2 [5:4], and 3 [7:6].
36	[11:0]	FFF	PBLKSCP1	PBLK sequence—Change Position 1.
37	[11:0]	FFF	PBLKSCP2	PBLK sequence—Change Position 2.
38	[11:0]	FFF	PBLKSCP3	PBLK sequence—Change Position 3.

Table 13. HBLK Register Map

Address	Data Bit Content	Default (Hex)	Name	Description (the HBLKSCP0 Always Starts at Line 0)
40	[0]	0	TESTMODE	Test mode. Always set = 0 if accessed.
41	[0]	0	TESTMODE	Test mode. Always set = 0 if accessed.
42	[0]	1	TESTMODE	Test mode. Always set = 1 if accessed.
43	[3:0]	F	HBLKMASK	HBLK internal masking polarity. 0 = mask H1 low; 1 = mask H1 high.
44	[23:0]	FFFFFF	HBLKTOG12_0	Sequence 0. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
45	[23:0]	FFFFFF	HBLKTOG34_0	Sequence 0. Toggle Position 3 [11:0] and Toggle Position 4 [23:12].
46	[23:0]	FFFFFF	HBLKTOG56_0	Sequence 0. Toggle Position 5 [11:0] and Toggle Position 6 [23:12].
47	[23:0]	FFFFFF	HBLKTOG12_1	Sequence 1. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
48	[23:0]	FFFFFF	HBLKTOG34_1	Sequence 1. Toggle Position 3 [11:0] and Toggle Position 4 [23:12].
49	[23:0]	FFFFFF	HBLKTOG56_1	Sequence 1. Toggle Position 5 [11:0] and Toggle Position 6 [23:12].
4A	[23:0]	FFFFFF	HBLKTOG12_2	Sequence 2. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
4B	[23:0]	FFFFFF	HBLKTOG34_2	Sequence 2. Toggle Position 3 [11:0] and Toggle Position 4 [23:12].
4C	[23:0]	FFFFFF	HBLKTOG56_2	Sequence 2. Toggle Position 5 [11:0] and Toggle Position 6 [23:12].
4D	[23:0]	FFFFFF	HBLKTOG12_3	Sequence 3. Toggle Position 1 [11:0] and Toggle Position 2 [23:12].
4E	[23:0]	FFFFFF	HBLKTOG34_3	Sequence 3. Toggle Position 3 [11:0] and Toggle Position 4 [23:12].
4F	[23:0]	FFFFFF	HBLKTOG56_3	Sequence 3. Toggle Position 5 [11:0] and Toggle Position 6 [23:12].
50	[7:0]	00	HBLKSPTR	HBLK sequence pointers for Region 0 [1:0], 1 [3:2], 2 [5:4], and 3 [7:6].
51	[11:0]	FFF	HBLKSCP1	HBLK sequence—Change Position 1.
52	[11:0]	FFF	HBLKSCP2	HBLK sequence—Change Position 2.
53	[11:0]	FFF	HBLKSCP3	HBLK sequence—Change Position 3.

Table 14. CHN_A and CHN_B H1 to H4, RG, SHP, SHD Register Map

Address	Data Bit Content	Default (Hex)	Name	Description
60	[12:0]	01001	H1CONTROL	H1 signal control. Polarity [0] (0 = inversion; 1 = no inversion). H1 positive edge location [6:1]. H1 negative edge location [12:7].
61	[12:0]	00801	RGCONTROL	RG signal control. Polarity [0] (0 = inversion; 1 = no inversion). RG positive-edge location [6:1]. RG negative-edge location [12:7].
62	[14:0]	0	DRVCONTROL	Drive-strength control for H1X [2:0], H2X [5:3], H3X [8:6], H4X [11:9], and RG_X [14:12]. Drive-current values: 0 = off, 1 = 4.3 mA, 2 = 8.6 mA, 3 = 12.9 mA, 4 = 17.2 mA, 5 = 21.5 mA, 6 = 25.8 mA, 7 = 30.1 mA.
63	[11:0]	00024	SAMPCONTROL	SHP/SHD sample control. SHP sampling location [5:0]. SHD sampling location [11:6].
64	[5:0]	0	DOUTPHASE	DOUT phase control.

Table 15. CHN_A and CHN_B AFE Operation Register Detail

Address	Data Bit Content	Default (Hex)	Name	Description
00	[1:0]	0	PWRDOWN	0 = normal operation; 1 = reference standby; 2/3 = total power-down.
	[2]	1	CLPENABLE	0 = disable CLPOB; 1 = enable CLPOB.
	[3]	0	CLPSPEED	0 = select normal CLPOB settling; 1 = select fast CLPOB settling.
	[4]	0	FASTUPDATE	0 = ignore VGA update; 1 = very fast clamping when VGA is updated.
	[5]	0	PBLK_LVL	DOUT value during PBLK; 0 = blank to zero; 1 = blank to clamp level.
	[7:6]	0	TEST MODE	Internal test mode. Should always be set = 3.
	[8]	0	DCBYP	0 = enable dc restore circuit; 1 = bypass dc restore circuit during PBLK.
	[9]	0	TESTMODE	Test operation only. Set = 0.
	[11:10]	0	TESTMODE	Test operation only. Set = 0.

Table 16. CHN_A and CHN_B AFE Control Register Detail

Address	Data Bit Content	Default (Hex)	Name	Description
03	[1:0]	0	TESTMODE	Test operation only. Set = 0.
	[2]	1	TESTMODE	Test operation only. Set = 0.
	[3]	0	DOUTDISABLE	0 = data outputs are driven; 1 = data outputs are three-stated.
	[4]	0	DOUTLATCH	0 = latch data outputs with DOUT phase; 1 = output latch transparent.
	[5]	0	GRAYENCODE	0 = binary encode data outputs; 1 = gray encode data outputs.

CHANNEL A AND CHANNEL B PRECISION TIMING

HIGH SPEED TIMING GENERATION

The AD9942 generates flexible, high speed timing signals using the *Precision Timing* core for both channels. This core is the foundation for generating the timing used for both the CCD and the AFE, the reset gate RG_X, the horizontal drivers H1X to H4X, and the SHP/SHD sample clocks. A unique architecture makes it routine for the system designer to optimize image quality by providing precise control over the horizontal CCD readout and the AFE correlated double sampling.

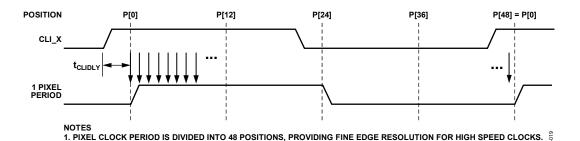
TIMING RESOLUTION

The *Precision Timing* core uses a $1\times$ master clock input (CLI) as a reference. This clock should be the same as the CCD pixel clock frequency. Figure 16 illustrates how the internal timing core divides the master clock period into 48 steps or edge positions. Therefore, the edge resolution of the *Precision Timing* core is ($t_{\text{CLI}}/48$). For more information on using the CLI input, see the Applications Information section.

HIGH SPEED CLOCK PROGRAMMABILITY

Figure 17 shows how the high speed clocks, RG_X, H1X to H4X, SHP, and SHD, are generated. The RG_X pulse has programmable rising and falling edges and can be inverted using the polarity control. The horizontal clock, H1, has programmable rising and falling edges and polarity control. The H2 clock is always the inverse of the H1 clock. Table 17 summarizes the high speed timing registers and their parameters.

Each edge location setting is six bits wide, but only 48 valid edge locations are available. Therefore, the register values are mapped into four quadrants, with each quadrant containing 12 edge locations. Table 18 shows the correct register values for the corresponding edge locations.



2. THERE IS A FIXED DELAY FROM THE CLI_X INPUT TO THE INTERNAL PIXEL PERIOD POSITIONS ($t_{CLIDLY} = 6$ ns TYP).

Figure 16. High Speed Clock Resolution from CLI

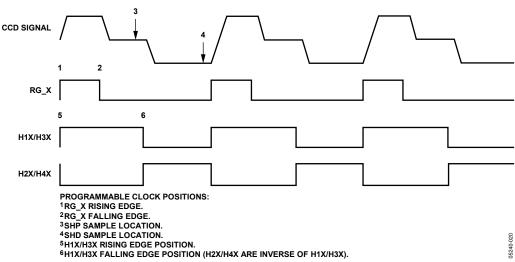


Figure 17. High Speed Clock Programmable Locations

Table 17. Channel A and Channel B H1X to H4X CONTROL, RG_X CONTROL, DRVCONTROL, and SAMPCONTROL Register Parameters

Parameter	Length (Bit)	Range	Description
Polarity	1	High/low	Polarity control for H1X and RG_X (0 = no inversion; 1 = inversion).
Positive Edge	6	0 to 47 edge locations	Positive-edge location for H1X, H3X, and RG_X.
Negative Edge	6	0 to 47 edge locations	Negative-edge location for H1X and RG_X.
Sample Location	6	0 to 47 sample locations	Sampling location for SHP and SHD.
Drive Control	3	0 to7 current steps	Drive current for H1X to H4X and RG_X outputs, 0 to 7 steps of 4.1 mA each.
DOUT Phase	6	0 to 47 edge locations	Phase location of data outputs with respect to pixel period.

Table 18. Channel A and Channel B Precision Timing Edge Locations

Quadrant	Edge Location (Decimal)	Register Value (Decimal)	Register Value (Binary)
I	0 to 11	0 to 11	000000 to 001011
II	12 to 23	16 to 27	010000 to 011011
III	24 to 35	32 to 43	100000 to 101011
IV	36 to 47	48 to 59	110000 to 111011

H DRIVER AND RG OUTPUTS

In addition to the programmable timing positions, the AD9942 features on-chip output drivers for the RG_X and H1X to H4X outputs. These drivers are powerful enough to drive the CCD inputs directly. The H-driver and RG-driver currents can be adjusted for optimum rise and fall time into a particular load by using the DRVCONTROL register (Address 0x62). The DRVCONTROL register is divided into five 3-bit values, each adjustable in 4.1 mA increments. The minimum setting of 0 is equal to off, or three-state, and the maximum setting of 7 is equal to 30.1 mA.

As shown in Figure 18, the H2X/H4X outputs are inverses of H1X. The internal propagation delay resulting from the signal inversion is less than l ns, which is significantly less than the typical rise time driving the CCD load. This results in a H1X/H2X crossover voltage at approximately 50% of the output swing. The crossover voltage is not programmable.

DIGITAL DATA OUTPUTS

The AD9942 data output phase is programmable using the DOUTPHASE register (Address 0x64). Any edge from 0 to 47 can be programmed, as shown in Figure 19. The pipeline delay for the digital data output is shown in Figure 20.

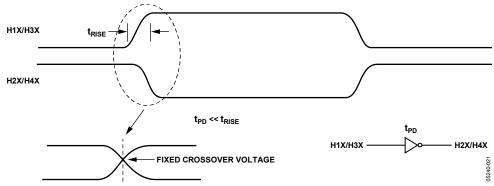
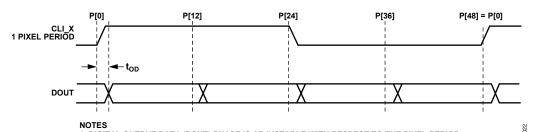
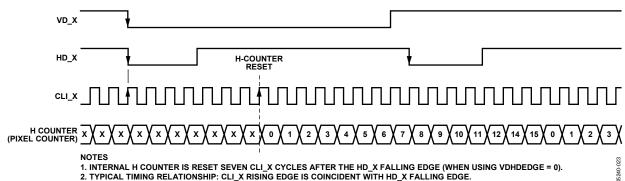


Figure 18. H-Clock Inverse Phase Relationship



1. DIGITAL OUTPUT DATA (DOUT) PHASE IS ADJUSTABLE WITH RESPECT TO THE PIXEL PERIOD.
2. WITHIN ONE CLOCK PERIOD, THE DATA TRANSITION CAN BE PROGRAMMED TO ANY OF THE 48 LOCATIONS.

Figure 19. Digital Output Phase Adjustment



1. INTERNAL H COUNTER IS RESET SEVEN CLI_X CYCLES AFTER THE HD_X FALLING EDGE (WHEN USING VDHDEDGE = 0).

2. TYPICAL TIMING RELATIONSHIP: CLI_X RISING EDGE IS COINCIDENT WITH HD_X FALLING EDGE.

Figure 20. Pipeline Delay for Channel A and Channel B Digital Data Output

CHANNEL A AND CHANNEL B HORIZONTAL CLAMPING AND BLANKING

The AD9942 horizontal clamping and blanking pulses are fully programmable to suit a variety of applications. Individual sequences are defined for each signal, which are then organized into multiple regions during image readout. This allows the dark pixel clamping and blanking patterns to be changed at each stage of the readout to accommodate different image transfer timing and high speed line shifts.

INDIVIDUAL CLPOB AND PBLK SEQUENCES

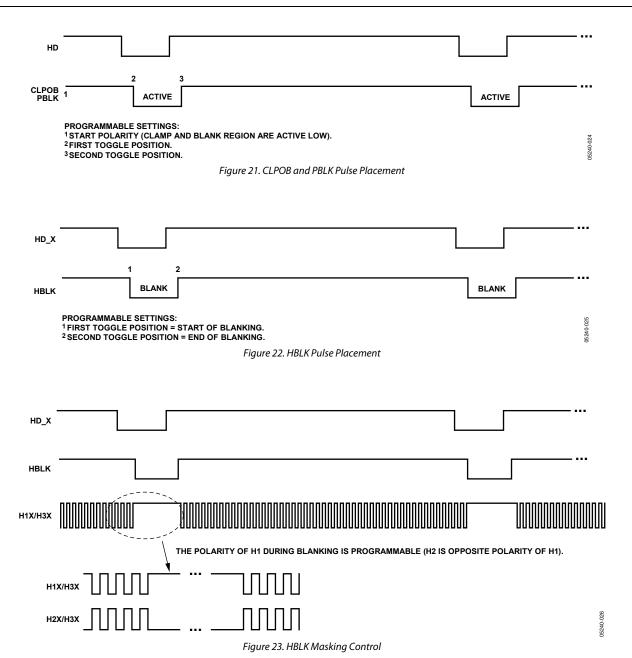
The AFE horizontal timing consists of CLPOB and PBLK, as shown in Figure 21. These two signals are independently programmed using the parameters shown in Table 19. The start polarity, first toggle position, and second toggle position are fully programmable for each signal. The CLPOB and PBLK signals are active low and should be programmed accordingly. Up to four individual sequences can be created for each signal.

INDIVIDUAL HBLK SEQUENCES

The HBLK programmable timing, shown in Figure 22, is similar to CLPOB and PBLK. However, there is no start polarity control. Only the toggle positions are used to designate the start and stop positions of the blanking period. Additionally, there is a polarity control, HBLKMASK, which designates the polarity of the horizontal clock signal H1 during the blanking period. Setting HBLKMASK high sets H1 low and H2 high during the blanking, as shown in Figure 23. Up to four individual sequences are available for HBLK.

Table 19. Channel A and Channel B CLPOB and PBLK Individual Sequence Parameters

	Length		
Parameter	(Bit)	Range	Description
Polarity	1	High/low	Starting polarity of CLPOB and PBLK pulses for Sequences 0 to 3.
Toggle Position 1	12	0 to 4095 pixel locations	First toggle position within the line for Sequences 0 to 3.
Toggle Position 2	12	0 to 4095 pixel locations	Second toggle position within the line for Sequences 0 to 3.



CHANNEL A AND CHANNEL B SPECIAL HBLK PATTERNS

Six toggle positions are available for HBLK. Typically, only two of the toggle positions are used to generate the standard HBLK interval. However, the additional toggle positions can be used to generate special HBLK patterns, as shown in Figure 24. The pattern in this example uses all six toggle positions to generate two extra groups of pulses during the HBLK interval. By changing the toggle positions, different patterns can be created.

HORIZONTAL SEQUENCE CONTROL

The AD9942 uses sequence change positions (SCPs) and sequence pointers (SPTRs) to organize the individual horizontal sequences. Up to four SCPs are available to divide the readout

into four separate regions, as shown in Figure 25. The SCP0 is always hard-coded to Line 0, and SCP1 to SCP3 are register programmable. During each region bounded by the SCP, the SPTR registers designate which sequence is used by each signal. CLPOB, PBLK, and HBLK each have a separate set of SCPs. For example, CLPOBSCP1 defines Region 0 for CLPOB, and in that region any of the four CLPOB sequences can be selected with the CLPOBSPTR register. The next SCP defines a new region, in which each signal can be assigned to a different individual sequence. The sequence control registers are detailed in Table 21.

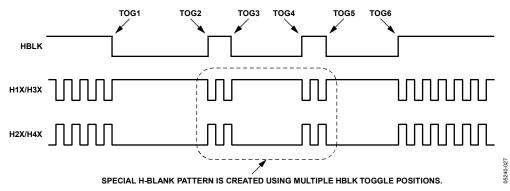


Figure 24. Generating Special HBLK Patterns

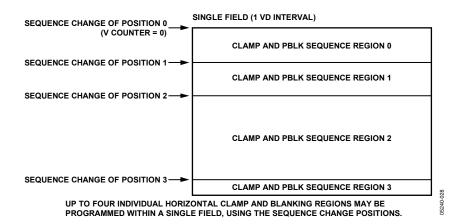


Figure 25. CLPOB and PBLK Sequence Flexibility